Features

- Single 3.3V ± 10% Supply
- Fast Read Access Time 200 ns
- Automatic Page Write Operation

Internal Address and Data Latches for 128-Bytes

Internal Control Timer

Fast Write Cycle Time

Page Write Cycle Time - 10 ms Maximum

1 to 128-Byte Page Write Operation

Low Power Dissipation

15 mA Active Current

20 μA CMOS Standby Current

- Hardware and Software Data Protection
- DATA Polling for End of Write Detection
- High Reliability CMOS Technology Endurance: 100,000K Cycles

Data Detention: 10 Veers

- Data Retention: 10 Years
 JEDEC Approved Byte-Wide Pinout
- Commercial and Industrial Temperature Ranges

Description

The AT28LV010 is a high-performance 3-volt only Electrically Erasable and Programmable Read Only Memory. Its 1 megabit of memory is organized as 131,072 words by 8 bits. Manufactured with Atmel's advanced nonvolatile CMOS technology, the device offers access times to 200 ns with power dissipation of just 54 mW. When the device is deselected, the CMOS standby current is less than 20 μ A.

Pin Configurations

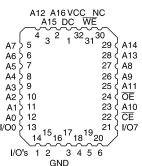
(continued)

Pin Name	Function
A0 - A16	Addresses
CE	Chip Enable
ŌĒ	Output Enable
WE	Write Enable
I/O0 - I/O7	Data Inputs/Outputs
NC	No Connect
DC	Don't Connect

PDIP Top View

		\neg		l
NC □	- 1	\circ	32	⊐ vcc
A16 □	2		31	□ WE
A15 □	3		30	□ NC
A12 □	4		29	□ A14
A7 □	5		28	□ A13
A6 □	6		27	□ A8
A5 □	7		26	□ A9
A4 □	8		25	□ A11
A3 □	9		24	□ OE
A2 🗆	10		23	□ A10
A1 □	11		22	□ CE
A0 □	12		21	□ I/O7
I/O0 □	13		20	□ I/O6
I/O1 🗆	14		19	□ I/O5
I/O2 🗆	15		18	□ I/O4
GND □	16		17	□ I/O3
	1			l

PLCC Top View



TSOP Top View

	A11 💆		1	32		Þ	OE	
A9	A8 🗆	2	3	30	31	Б	CE	A10
A13		4			29	Þ		1/07
NC	A14 =	6	5	28	27	Б	I /O6	I/O5
	WE 5	-	7	26		Þ	I /O4	
VCC	NC =	8	9	24	25	Б	GND	I/O3
A16		10			23	Þ		1/02
A12	A15	12	11	22	21	Н	I /O1	I/O0
	A7 ⊑	1	13	20		Þ	A0	
A6	A5 □	14	15	18	19	K.	A2	A1
Δ/	A3 =	16	15	10	17	F	AZ	Δ3

1 Megabit (128K x 8) Low Voltage Paged CMOS E²PROM

0395A



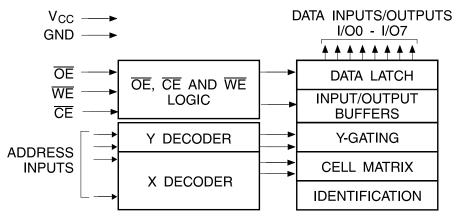


Description (Continued)

The AT28LV010 is accessed like a Static RAM for the read or write cycle without the need for external components. The device contains a 128-byte page register to allow writing of up to 128-bytes simultaneously. During a write cycle, the address and 1 to 128-bytes of data are internally latched, freeing the address and data bus for other operations. Following the initiation of a write cycle, the device will automatically write the latched data using an internal control timer. The end of a write cycle can be detected by DATA polling of I/O7. Once the end of a write cycle has been detected a new access for a read or write can begin.

Atmel's 28LV010 has additional features to ensure high quality and manufacturability. The device utilizes internal error correction for extended endurance and improved data retention characteristics. Software data protection is implemented to guard against inadvertent writes. The device also includes an extra 128-bytes of E²PROM for device identification or tracking.

Block Diagram



Absolute Maximum Ratings*

Temperature Under Bias55°C to +125°C
Storage Temperature65°C to +150°C
All Input Voltages (including NC Pins) with Respect to Ground0.6V to +6.25V
All Output Voltages with Respect to Ground0.6V to V _{CC} + 0.6V
Voltage on $\overline{\text{OE}}$ and A9 with Respect to Ground0.6V to +13.5V

*NOTICE: Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

Device Operation

READ: The AT28LV010 is accessed like a Static RAM. When CE and OE are low and WE is high, the data stored at the memory location determined by the address pins is asserted on the outputs. The outputs are put in the high impedance state when either CE or OE is high. This dualline control gives designers flexibility in preventing bus contention in their system.

WRITE: The write operation of the AT28LV010 allows 1 to 128-bytes of data to be written into the device during a single internal programming period. Each write operation must be preceded by the software data protection (SDP) command sequence. This sequence is a series of three unique write command operations that enable the internal write circuitry. The command sequence and the data to be written must conform to the software protected write cycle timing. Addresses are latched on the falling edge of WE or CE, whichever occurs last and data is latched on the rising edge of WE or CE, whichever occurs first. Each successive byte must be written within 150 µs (tBLC) of the previous byte. If the t_{BLC} limit is exceeded the AT28LV010 will cease accepting data and commence the interal programming operation. If more than one data byte is to be written during a single programming operation, they must reside on the same page as defined by the state of the A7 - A16 inputs. For each WE high to low transition during the page write operation, A7 - A16 must be the same.

The A0 to A6 inputs are used to specify which bytes within the page are to be written. The bytes may be loaded in any order and may be altered within the same load period. Only bytes which are specified for writing will be written; unnecessary cycling of other bytes within the page does not occur.

DATA POLLING: The AT28LV010 features DATA Polling to indicate the end of a write cycle. During a byte or page write cycle an attempted read of the last byte written will result in the complement of the written data to be presented on I/O7. Once the write cycle has been completed, true data is <u>valid</u> on all outputs, and the next write cycle may begin. DATA Polling may begin at anytime during the write cycle.

TOGGLE BIT: In addition to DATA Polling the AT28LV010 provides another method for determining the end of a write cycle. During the write operation, successive attempts to read data from the device will result in I/O6 toggling between one and zero. Once the write has completed, I/O6 will stop toggling and valid data will be read. Reading the toggle bit may begin at any time during the write cycle.

DATA PROTECTION: If precautions are not taken, inadvertent writes may occur during transitions of the host system power supply. Atmel has incorporated both hardware and software features that will protect the memory against inadvertent writes.

HARDWARE PROTECTION: Hardware features protect against inadvertent writes to the AT28LV010 in the following ways: (a) VCC power-on delay - once VCC has reached 2.0V (typical) the device will automatically time out 5 ms (typical) before allowing a write: (b) write inhibit - holding any one of OE low, CE high or WE high inhibits write cycles; (c) noise filter - pulses of less than 15 ns (typical) on the WE or CE inputs will not initiate a write cycle.

SOFTWARE DATA PROTECTION: The AT28LV010 incorporates the industry standard software data protection (SDP) function. Unlike standard 5-volt only E²PROM's, the AT28LV010 has SDP enabled at all times. Therefore, all write operations must be preceded by the SDP command sequence.

The data in the 3-byte command sequence is not written to the device; the addresses in the command sequence can be utilized just like any other location in the device. Any attempt to write to the device without the 3-byte sequence will start the internal timers. No data will be written to the device. However, for the duration of twc, read operations will effectively be polling operations.





DC and AC Operating Range

		AT28LV010-20	AT28LV010-25
Operating	Com.	0°C - 70°C	0°C - 70°C
Temperature (Case)	Ind.	-40°C - 85°C	-40°C - 85°C
Vcc Power Supply		3.3V ± 5%	3.3V ± 10%

Operating Modes

Mode	CE	ŌE	WE	I/O
Read	VIL	VIL	ViH	Dout
Write (2)	VIL	ViH	VIL	DIN
Standby/Write Inhibit	VIH	X ⁽¹⁾	Χ	High Z
Write Inhibit	Χ	Χ	VIH	
Write Inhibit	Χ	VIL	Χ	
Output Disable	Х	Vih	Х	High Z

Notes: 1. X can be V_{IL} or V_{IH} .

2. Refer to AC Programming Waveforms.

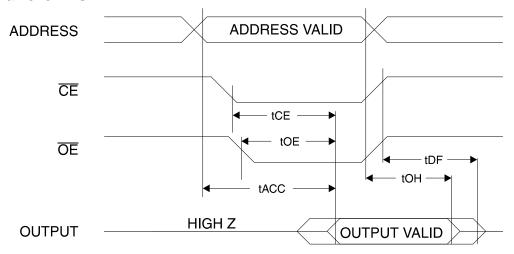
DC Characteristics

Symbol	Parameter	Condition	Min	Max	Units	
ILI	Input Load Current	$V_{IN} = 0V$ to V_{CC}		1	μΑ	
ILO	Output Leakage Current	$V_{I/O} = 0V$ to V_{CC}		1	μΑ	
lon	V Chan dha Camarat CMOC	V Standby Correct OMOS OF	$\overline{CE} = V_{CC} - 0.3V$ to $V_{CC} + 1V$	Com.	20	μΑ
I _{SB}	V _{CC} Standby Current CMOS	CE = VCC - 0.3V to VCC + 1V	Ind.	50	μΑ	
Icc	V _{CC} Active Current	$f = 5 \text{ MHz}$; $I_{OUT} = 0 \text{ mA}$; $V_{CC} = 3.6 \text{V}$		15	mA	
VIL	Input Low Voltage			8.0	V	
VIH	Input High Voltage		2.0		V	
VoL	Output Low Voltage	$I_{OL} = 1.6 \text{ mA}; V_{CC} = 3.0 \text{V}$.45	٧	
Voн	Output High Voltage	$I_{OH} = -100 \mu A; V_{CC} = 3.0 V$	2.4		V	

AC Read Characteristics

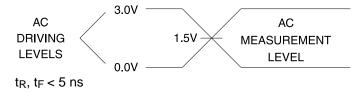
		AT28L\	AT28LV010-20 A		AT28LV010-25	
Symbol	Parameter	Min	Max	Min	Max	Units
tacc	Address to Output Delay		200		250	ns
t _{CE} ⁽¹⁾	CE to Output Delay		200		250	ns
toE (2)	OE to Output Delay	0	80	0	100	ns
t _{DF} (3, 4)	CE or OE to Output Float	0	55	0	60	ns
ton	Output Hold from OE, CE or Address, whichever occurred first	0		0		ns

AC Read Waveforms (1, 2, 3, 4)

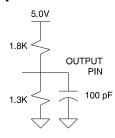


- Notes: 1. $\overline{\text{CE}}$ may be delayed up to t_{ACC} t_{CE} after the address transition without impact on t_{ACC} .
 - 2. OE may be delayed up to t_{CE} t_{OE} after the falling edge of CE without impact on t_{CE} or by t_{ACC} t_{OE} after an address change without impact on t_{ACC}.
- 3. t_{DF} is specified from \overline{OE} or \overline{CE} whichever occurs first $(C_L = 5pF)$.
- 4. This parameter is characterized and is not 100% tested.

Input Test Waveforms and Measurement Level



Output Test Load



Pin Capacitance (f = 1 MHz, T = 25° C) (1)

	Тур	Max	Units	Conditions
C _{IN}	4	6	pF	$V_{IN} = 0V$
Cout	8	12	pF	$V_{OUT} = 0V$

Note: 1. This parameter is characterized and is not 100% tested.





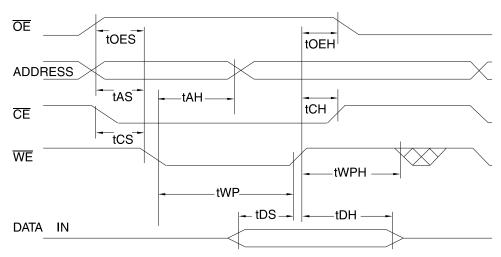
AC Write Characteristics (1)

Symbol	Parameter	Min	Max	Units
tas, toes	Address, OE Set-up Time	0		ns
t _{AH}	Address Hold Time	100		ns
tcs	Chip Select Set-up Time	0		ns
tcH	Chip Select Hold Time	0		ns
twp	Write Pulse Width (WE or CE)	200		ns
tos	Data Set-up Time	100		ns
t _{DH} , t _{OEH}	Data, OE Hold Time	10		ns

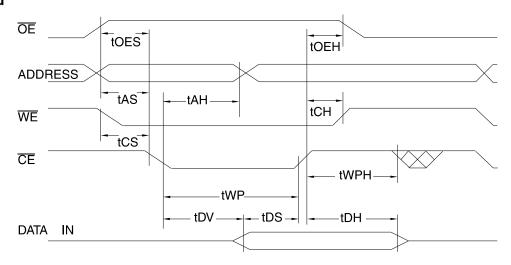
Note: 1. All write operations must be preceded by the SDP command sequence.

AC Write Waveforms

WE Controlled



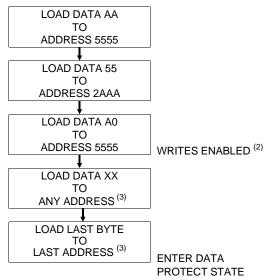
CE Controlled



Software Protected Write Characteristics

Symbol	Parameter	Min	Max	Units
twc	Write Cycle Time		10	ms
t _{AS}	Address Set-up Time	0		ns
tah	Address Hold Time	100		ns
t _{DS}	Data Set-up Time	100		ns
tDH	Data Hold Time	10		ns
twp	Write Pulse Width	200		ns
tBLC	Byte Load Cycle Time		150	μs
twpH	Write Pulse Width High	100		ns

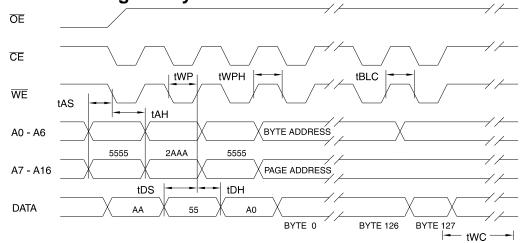
Programming Algorithm



Notes:

- 1. Data Format: I/O7 I/O0 (Hex); Address Format: A14 - A0 (Hex).
- Data protect state will be re-activated at the end of program cycle.
- 3. 1 to 128-bytes of data are loaded.

Software Protected Program Cycle Waveforms (1, 2, 3)



Notes: 1. A0 - A14 must conform to the addressing sequence for the first 3-bytes as shown above.

- 2. After the command sequence has been issued and <u>a page write</u> operation follows, the page address inputs (A7 A16) must be the same for each high to low transition of WE (or CE).
- 3. $\overline{\text{OE}}$ must be high only when $\overline{\text{WE}}$ and $\overline{\text{CE}}$ are both low.





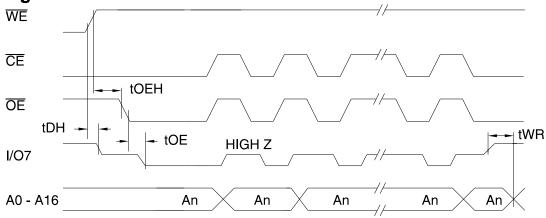
Data Polling Characteristics (1)

Symbol	Parameter	Min	Тур	Max	Units
tDH	Data Hold Time	10			ns
toeh	OE Hold Time	10			ns
toe	OE to Output Delay (2)				ns
t _{WR}	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See AC Read Characteristics.

Data Polling Waveforms



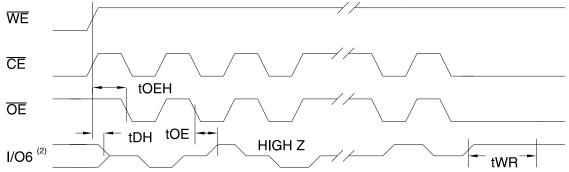
Toggle Bit Characteristics (1)

Symbol	Parameter	Min	Тур	Max	Units
tDH	Data Hold Time	10			ns
toeh	OE Hold Time	10			ns
toE	OE to Output Delay (2)				ns
toehp	OE High Pulse	150			ns
twR	Write Recovery Time	0			ns

Notes: 1. These parameters are characterized and not 100% tested.

2. See AC Read Characteristics.

Toggle Bit Waveforms



Notes: 1. Toggling either \overline{OE} or \overline{CE} or both \overline{OE} and \overline{CE} will operate toggle bit.

2. Beginning and ending state of I/O6 will vary.

3. Any address location may be used but the address should not vary.

Ordering Information (1)

tACC	Icc	(mA)	Ondonio v Oodo	5 .	0 11 0	
(ns)	Active	Standby	Ordering Code	Package	Operation Range	
200	15	0.2	AT28LV010-20JC AT28LV010-20PC AT28LV010-20TC	32J 32P6 32T	Commercial (0° to 70°C)	
	15	0.2	AT28LV010-20JI AT28LV010-20PI AT28LV010-20TI	32J 32P6 32T	Industrial (-40° to 85°C)	
250	15	0.2	AT28LV010-25JC AT28LV010-25PC AT28LV010-25TC	32J 32P6 32T	Commercial (0° to 70°C)	
	15	0.2	AT28LV010-25JI AT28LV010-25PI AT28LV010-25TI	32J 32P6 32T	Industrial (-40° to 85°C)	

Note: 1. See Valid Part Number table below.

Valid Part Numbers

The following table lists standard Atmel products that can be ordered.

Device Numbers	Speed	Package and Temperature Combinations
AT28LV010	20	JC, JI, PC, PI, TC, TI
AT28LV010	25	JC, JI, PC, PI, TC, TI

Package Type				
32J	32 Lead, Plastic J-Leaded Chip Carrier (PLCC)			
32P6	32 Lead, 0.600" Wide, Plastic Dual Inline Package (PDIP)			
32T	32 Lead, Plastic Thin Small Outline Package (TSOP)			

